

April 2013

# FGA50N100BNTD 1000 V NPT Trench IGBT

## **General Description**

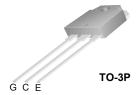
Using Fairchild<sup>®</sup>'s proprietary trench design and advanced NPT technology, the 1000V NPT IGBT offers superior conduction and switching performances, high avalanche ruggedness and easy parallel operation. This device offers the optimum performance for hard switching application such as UPS, welder applications.

## **Features**

- · High Speed Switching
- Low Saturation Voltage :  $V_{CE(sat)}$  = 2.5 V @  $I_C$  = 60 A
- High Input Impedance
- · Built-in Fast Recovery Diode

## **Application**

UPS, Welder, Induction Heating, Microwave Oven





## Absolute Maximum Ratings T<sub>C</sub> = 25°C unless otherwise noted

Symbol	Description		FGA50N100BNTD	Unit
V <sub>CES</sub>	Collector-Emitter Voltage		1000	V
V <sub>GES</sub>	Gate-Emitter Voltage		± 25	V
	Collector Current	@ T <sub>C</sub> = 25°C	50	Α
IC	Collector Current	@ T <sub>C</sub> = 100°C	35	Α
I <sub>CM (1)</sub>	Pulsed Collector Current		100	Α
I <sub>F</sub>	Diode Continuous Forward Current	@ T <sub>C</sub> = 100°C	15	Α
$P_{D}$	Maximum Power Dissipation	@ T <sub>C</sub> = 25°C	156	W
	Maximum Power Dissipation	@ T <sub>C</sub> = 100°C	63	W
T <sub>J</sub>	Operating Junction Temperature		-55 to +150	°C
T <sub>stg</sub>	Storage Temperature Range		-55 to +150	°C
T <sub>L</sub>	Maximum Lead Temp. for soldering Purposes, 1/8" from case for 5 second	ds	300	°C

### Notes:

(1) Repetitive rating : Pulse width limited by max. junction temperature

# **Thermal Characteristics**

Symbol	Parameter	Тур.	Max.	Unit
$R_{\theta JC}(IGBT)$	Thermal Resistance, Junction-to-Case		0.8	°C/W
$R_{\theta JC}(DIODE)$	Thermal Resistance, Junction-to-Case		2.4	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient		25	°C/W

# **Package Marking and Ordering Information**

Device Marking	Device	Package	Packaging Type  Qty per Tube		Max Qty per Box
FGA50N100BNTD	FGA50N100BNTDTU	TO-3P	Rail / Tube	30ea	-

# Electrical Characteristics of IGBT T<sub>C</sub> = 25°C unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
Off Cha	racteristics					
BV <sub>CES</sub>	Collector Emitter Breakdown Voltage	$V_{GE}$ = 0V, $I_{C}$ = 1mA	1000			V
I <sub>CES</sub>	Collector Cut-Off Current	V <sub>CE</sub> = 1000V, V <sub>GE</sub> = 0V			1.0	mA
I <sub>GES</sub>	G-E Leakage Current	$V_{GE} = \pm 25, V_{CE} = 0V$			± 500	nA
On Chai	racteristics					
V <sub>GE(th)</sub>	G-E Threshold Voltage	$I_C$ = 60mA, $V_{CE}$ = $V_{GE}$	4.0	5.0	7.0	V
Collector to Em	Collector to Emitter	I <sub>C</sub> = 10A, V <sub>GE</sub> = 15V		1.5	1.8	V
V <sub>CE(sat)</sub>	Saturation Voltage	$I_C = 60A$ , $V_{GE} = 15V$		2.5	2.9	V
<b>Dynami</b> C <sub>ies</sub>	C Characteristics Input Capacitance			6000		pF
C <sub>oes</sub>	Output Capacitance	$V_{CE} = 10V_{,} V_{GE} = 0V_{,}$		260		pF
C <sub>res</sub>	Reverse Transfer Capacitance	f = 1MHz		200		pF
	ng Characteristics					•
t <sub>d(on)</sub>	Turn-On Delay Time	$V_{CC} = 600 \text{ V, } I_{C} = 60 \text{A,}$		140		ns
t <sub>r</sub>	Rise Time	$V_{CC} = 600 \text{ V, } I_C = 600 \text{ A,}$ $R_C = 51\Omega, V_{CF} = 15V,$		320		ns
t <sub>d(off)</sub>	Turn-Off Delay Time	Resistive Load, T <sub>C</sub> = 25°C		630		ns
t <sub>f</sub>	Fall Time	1.00.00.10 2000, 10 20 0		130	250	ns
$Q_{\alpha}$	Total Gate Charge	$V_{CF} = 600 \text{ V}, I_{C} = 60\text{A},$		275	350	nC
Q <sub>ge</sub>	Gate-Emitter Charge	$V_{CE} = 600 \text{ V, } I_{C} = 60A,$ $V_{GE} = 15\text{V}_{,}, T_{C} = 25^{\circ}\text{C}$		45		nC
0	Gate-Collector Charge	VGE - 13V,, 1C - 23 C		95		nC

# Electrical Characteristics of DIODE $T_C = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
	Diode Forward Voltage	I <sub>F</sub> = 15A		1.2	1.7	V
νFM	V <sub>FM</sub> Diode Forward Voltage	I <sub>F</sub> = 60A		1.8	2.1	V
t <sub>rr</sub>	Diode Reverse Recovery Time	I <sub>F</sub> = 60A di/dt = 20 A/us		1.2	1.5	us
lR	Instantaneous Reverse Current	VRRM = 1000V		0.05	2	uA

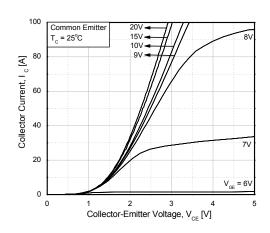


Fig 1. Typical Output Characteristics

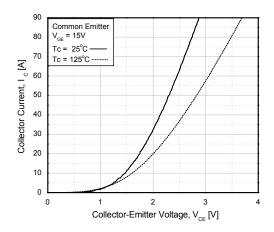


Fig 2. Typical Saturation Voltage Characteristics

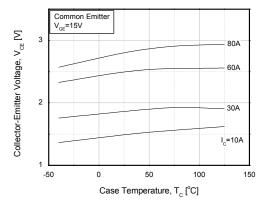


Fig 3. Saturation Voltage vs. Case
Temperature at Varient Current Level

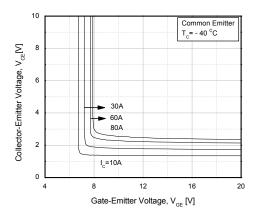


Fig 4. Saturation Voltage vs.  $V_{GE}$ 

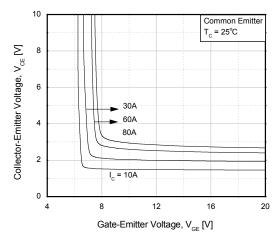


Fig 5. Saturation Voltage vs. V<sub>GE</sub>

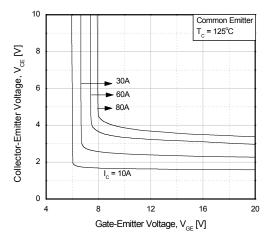


Fig 6. Saturation Voltage vs. V<sub>GE</sub>

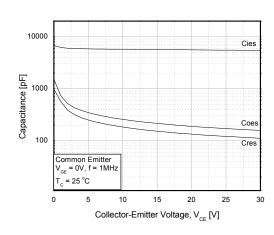
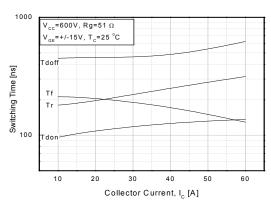


Fig 7. Capacitance Characteristics

Fig 8. Switching Characteristics vs. Gate Resistance



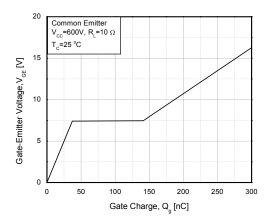
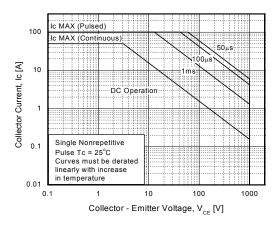


Fig 9. Switching Characteristics vs. Collector Current

Fig 10. Gate Charge Characteristics



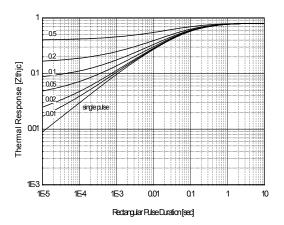


Fig 11. SOA Characteristics

Fig 12. Transient Thermal Impedance of IGBT

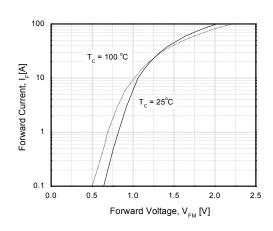


Fig 13. Forward Characteristics

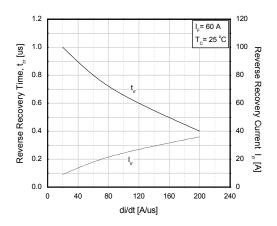


Fig 14. Reverse Recovery Characteristics vs. di/dt

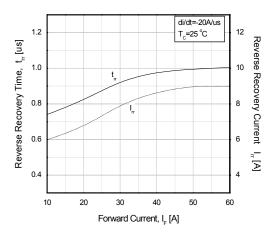


Fig 15. Reverse Recovery Characteristics vs. Forward Current

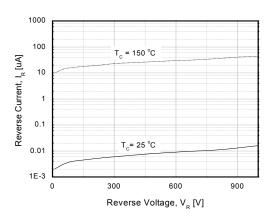


Fig 16. Reverse Current vs. Reverse Voltage

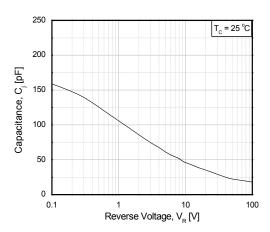


Fig 17. Junction capacitance

# **Mechanical Dimensions** TO-3PN 5.00 4.60 13.80 15.80 13.40 $\phi_{3.10}^{3.30}$ 1.65 15.40 5.20 1.45 4.80 (R0.50) 16.96 20.10 18.90 16.56 $\phi_{6.80}^{7.20}$ 19.70 18.50 3 3.70 (1.85)3.30 20.30 2.20 2.90 19.70 1.80 1.90 3.20 2.80 1.20 0.80 $\emptyset$ 0.55 (M) 0.75 0.55 5.45 5.45 NOTES: UNLESS OTHERWISE SPECIFIED A) THIS PACKAGE CONFORMS TO EIAJ SC-65 PACKAGING STANDARD. B) ALL DIMENSIONS ARE IN MILLIMETERS. C) DIMENSION AND TOLERANCING PER (R0.50) ASME14.5 ASME 14:3 D) DIMENSIONS ARE EXCLUSSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSSIONS. E) THIS PACKAGE IS INTENDED ONLY FOR TO3PN. F) DRAWING FILE NAME: TO3P03AREV4. **Dimensions in Millimeters**





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